


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590511	<b>Applicant(s)/Patent Under Reexamination</b>  CHRISTENSEN ET AL.
	<b>Examiner</b>  Thomas Diaz	<b>Art Unit</b>  4171

SEARCHED			
Class	Subclass	Date	Examiner
74	89.33, 89.37-39	06/12/2008	/TD/
192	56.62	06/12/2008	/TD/

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search done in Palm/eDAN.	06/12/2008	/TD/
Search of US and foreign patents done in EAST.	06/12/2008	/TD/
Consulted with Rodney Bonck, primary in 192.	06/12/2008	/TD/
Updated search done in EAST.	01/02/2009	/TD/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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